Overview of Tests on Radar Systems and Components

Application Note

Products:

Ι	R&S [®] SMU200A		R&S [®] FSV
Ι	R&S [®] SMF		R&S [®] FSVR
Ι	R&S [®] SMA100A		R&S [®] FSW
I	R&S [®] SMBV		R&S [®] NRP
I	R&S [®] FSU		R&S [®] RTO
		I	R&S [®] ZVA

The scope of the subject "radar" has expanded in the recent years in terms of its technical evolution and spreading of applications. This application note along with its corresponding white paper 1MA207 show how to use the R&S radar product portfolio to tackle test and measurement tasks in modern radar technology. Target groups are students who want to become familiar with radar issues as well as radar professionals who want to solve certain test and measurement tasks.

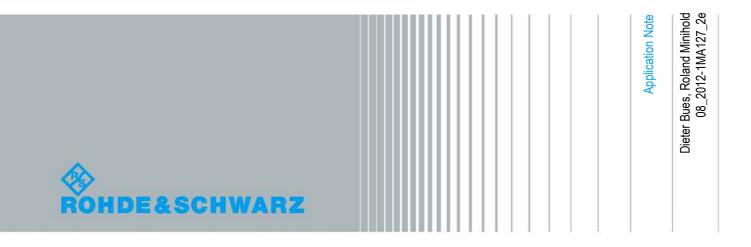


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1 Motivation

The scope of the subject "radar" has expanded in the recent years in terms of its technical evolution and spreading of applications. Main causes are that CAD / CAE tools are enabling a quicker and more predictable design and that highly integrated signals processors and post processing units are available for applications not possible at a nominal budget in the past.

Related improvement in test & measurement devices prompted an update of the former R&S radar Overview application note 1MA127, which has been separated into two documents. The 1MA207 "White Paper" describes the general topics, not related to the R&S product portfolio. This Application Note at hand is supplementary to the "White Paper".

The structure of this document now more directly addresses the target groups. Automotive (FM-CW) radar engineers most likely are interested in different topics compared to engineers from the Aerospace & Defense community, i.e. issues related to pulse generation and evaluation. Hence, A&D subjects are organized into the main chapter "Aerospace & Defense Applications", while automotive topics are assembled in the appropriate "Automotive" chapter. Subjects not fitting into any of these categories or which are important for both can be found in chapter "Special radar measurements".

Using this structure in conjunction with the complementing white paper, we hope to provide information on radar -T&M in condensed and well organized form to the main target groups

This application note closes with a short overview of core radar-related products from Rohde & Schwarz and a classification of our large radar T&M product portfolio.

2 Aerospace & Defense-Applications

2.1 Pulsed Signal Generation

Pulse radar with a rotating antenna

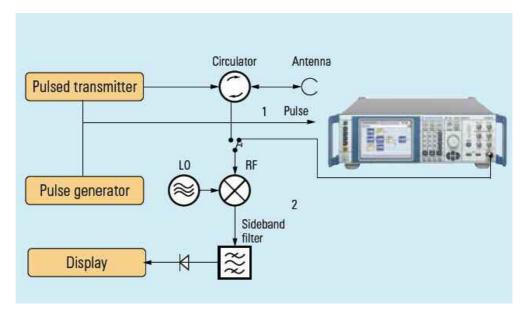


Figure 1: A pulse radar system using R&S SMF100A

The R&S SMF100A can be used to simulate pulsed radar applications with a rotating antenna. In this example (see Figure 1, the external pulse from the pulse generator is applied to the external pulse input of the R&S SMF100A and is used as a trigger for the internal pulse generator and modulator. You can delay this trigger in order to perform range and direction simulations and check them on the radar equipment's display.

The R&S SMF100A microwave signal generator can be equipped with the R&S SMF-K27 pulse train option to generate pulse sequences containing jitter or even staggered pulses (pulses with variable pulse pause lengths). This makes the R&S SMF100A ideal for performing sensitivity tests on radar receivers or for simulating pulse radar signals (without pulse compression). Pulse trains are created with an easy-to-use editor. Lengths of up to 1023 individual pulses are possible.

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Figure 2: SMF-K27 pulse train option on SMF

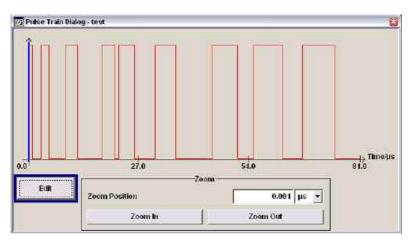


Figure 3: Pulse train as result of SMF-K27 pulse train option

Further information is available in Ref. [28]

2.2 Pulsed Signal Evaluation

For any radar system, the pulse power is the central parameter. Accordingly, we have an interest in investigating the individual pulses. This is particularly important with advanced radar systems in which the pulse width and the PRF are both variable. Here, it is important to analyze pulse power and shaping (slope steepness, pulse droop, overshoot, etc.). Suitable test instruments include wideband power sensors such as the R&S NRP-Z81 power sensor with versatile measurement functions. However, a spectrum analyzer with a wide IF bandwidth in zero span mode will provide even greater flexibility for assessing the measurement parameters.



Figure 4: Power Probes directly operated by means of a PC

The R&S NRP-Z81/85/86 are based on the latest power measurement technology. They offer all of the features of a conventional peak power meter in a very compact package. They can be operated with the NRP2 power meter or (like all of the R&S NRP sensors) with a Windows PC, e.g. as a cost-effective solution for performing radar transmitter tests in the field. No compromises were accepted in the areas of measurement accuracy and functionality. This makes the R&S NRP-Z81/85/86 very well suited for detailed analysis of radar signals with bandwidths of up to 30 MHz for individual pulses. In addition, the R&S NRP-Z81 also allows precision measurements of the average power of signals in the power level range from –60 dBm to +20 dBm. The actual frequency range is from 50 MHz to 18 GHz for the R&S NRP-Z81 and 50 MHz to 40 GHz for the R&S NRP-Z85/86.

R&S NRP Power Viewer Plus is easy-to-use test software that provides all internal features of the power probe to the user just via a control PC without the need of a dedicated instrument. This way measurement functions such as continuous average power, trace, statistics and data logging are available. Up to four thermal sensors which are directly connected to the PC via USB can be simultaneously evaluated in continuous average power mode. Various mathematical functions (e.g. sum, difference, ratio, SWR, etc.) are available for analyzing the measurement results produced by the sensors. Versatile trigger function (internal/external trigger, definable holdoff and dropout time) ensure correct measurements even under difficult trigger conditions.

In addition to the manual operation of power probes NRP Power viewer plus offers a scripting language which allows automatic test sequences to be created and being operated without the need of an extra software development environment.

Power Viewer Plus software is delivered along with power probes it can be operated under Windows, MAC OS X or Linux.

In addition to Power Viewer Plus, which is delivered along with NRP-Zx power probes, an additional software "NRPV" can be purchased. NRPV provides additional flexibility in handling multiple sensors simultaneously. Details on NRPV are available in Ref. [23], see reference list at the end of this document.

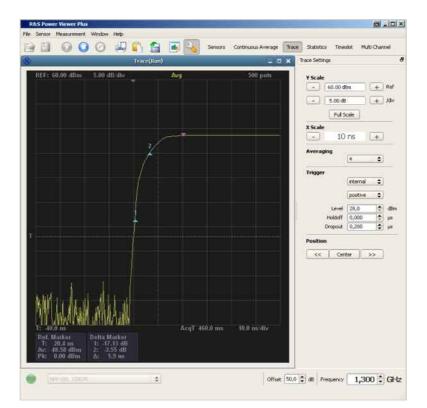


Figure 5: NRP Power Viewer Plus software, user interface

For repetitive signals, the R&S NRP Power Viewer Plus software provides high time resolution in conjunction with the R&S NRP-Z81, -Z85 and -Z86 power sensors to enable display of time-domain behavior even for very steep-edged pulses. See Fig. 5 and 6 .This allows determination of all of the relevant pulse parameters with high accuracy.

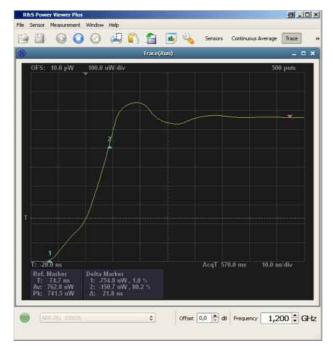


Figure 6: NRP Power Viewer Plus, rise-time measurement

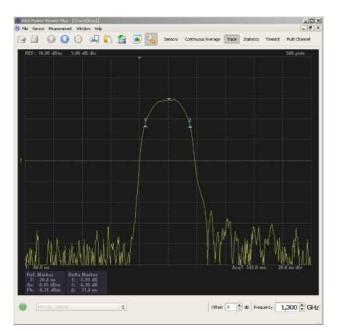
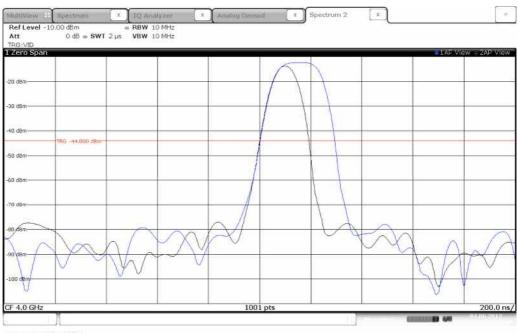


Figure 7: NRP Power Viewer Plus, pulse-width measurement

2.2.1 Pulse Measurements using a Spectrum Analyzer

The R&S FSW provides an optional analysis bandwidth up to 160 MHz. The peak power can be measured very accurately for pulse widths down to about 100 ns. See Fig. 8, 9 and 10:



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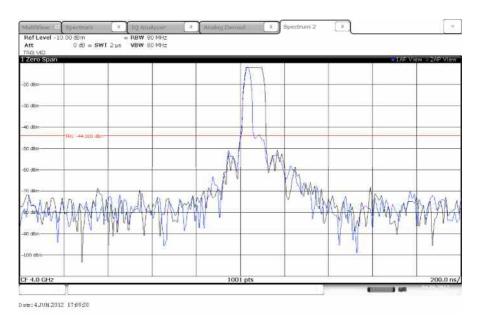


Figure 9: Zero-span measurement on pulsed signals 100ns and 50 ns

Zero-span measurement on a pulsed signal with RBW = 80 MHz and pulse widths of 100 ns and 200 ns. The peak power can be measured with little error for pulse widths as low as 100 ns.

When equipped with the R&S FSW-B8 option and the R&S FSW-B160 I/Q demodulation bandwidth extension, the R&S FSW can even deliver an I/Q demodulation bandwidth of 160 MHz. This makes it possible to measure peak power even for pulse widths < 30 ns; see Fig. 10.

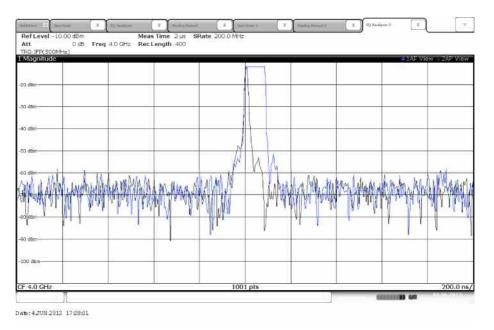


Figure 10: FSW zero-span measurement with extended I/Q demod. BW

2.2.2 Amplifier Testing: S-Parameters under Pulse Conditions

Components such as amplifiers are typically characterized in terms of their gain, frequency response, matching, and phase response by S-parameter measurements. S-parameter measurements are generally performed with a vector network analyzer using CW signals. However, this technique can be inadequate (or totally impractical) with pulse radar components such as radar transmitter amplifiers. The amplifier might behave differently in CW mode compared to pulse mode or might even be subject to thermal overloading.

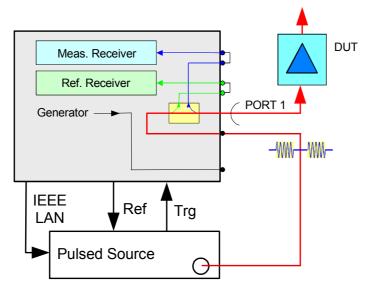


Figure 11: Sample circuit using a signal generator as pulse source

Fig. 11 shows a schematic diagram with a pulsed signal source such as the R&S SMF100A connected to a R&S ZVA vector network analyzer. Fig. 12 shows a detailed block diagram as an example of a test setup for pulsed S-parameter measurement on an L-band radar power amplifier.

The pulsed output signal of the SMF is amplified to the required drive power by a power amplifier operating in linear mode. Part of the input power, and of the reflected power of the amplifier module under test (DUT) is coupled by a bidirectional coupler and reduced by attenuators (20 dB) to the levels suitable for the ZVA reference and test inputs. The DUT output is connected to a 30 dB power attenuator. A part of the attenuated output signal is coupled by the directional coupler and fed via another 10 dB attenuator to port 2 of the ZVA. This way the decoupled signals are fed to the corresponding R&S ZVA receiver inputs for measurement of S11 and S21, details are provided in ref. [5].

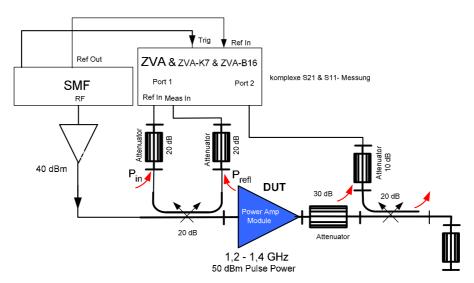


Figure 12: Testing L-band radar pulsed power transistor with R&S ZVA

2.2.3 Pulse-Profile Measurements

In pulse-profile mode, the R&S ZVA measures S-parameters vs. time. With its 30 MHz maximum measurement bandwidth and 80 MHz sampling rate, it is possible to determine the exact timing behavior of the S-parameters even when dealing with the very short pulses that are commonly encountered in radar technology. In pulse-profile mode, the R&S ZVA writes the raw data into its own RAM. Further signal processing such as filtering is then handled by the instrument software.

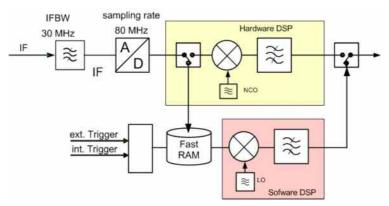


Figure 13: Pulse-profile technique within R&S ZVA

Fig. 14 illustrates an S-parameter measurement made in this manner vs. pulse duration on an L-band radar power transistor.

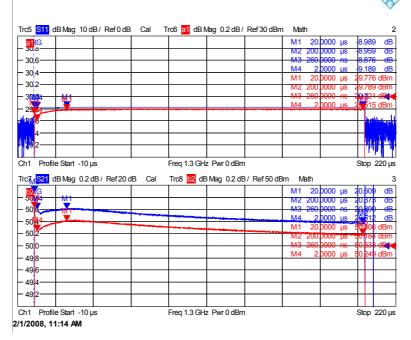


Figure 14: Parameters a1, b2 and s21 as result of ZVA's pulse-profile mode

2.3 Generation and Evaluation of more complex Radar Signals

It need to be stressed that there is a difference between "pulse generation" in the basic sense and generation of more complex baseband radar signals. For example basic pulse on/off ratios can be created with simple analog signal generators; however more complex radar signals require vector baseband signal creation. Trade-offs include On/Off ratio of signal blanking in analog signal generator and dynamic range of baseband system.

2.3.1 Software Tools to generate more complex Radar Signals

There are different ways of loading data into the ARB memory of a vector signal generator or I/Q modulation generator as shown in Fig. 15:

- The R&S (AFQ-/AMU-/SMx-)K6 pulse sequencer software simplifies generation of pulsed signals with complex modulation and also handles the transfer of the signals to the Rohde & Schwarz generators.
- 2. The ARB toolbox Plus (AN 1GP88) converts existing I/Q signals into the Rohde & Schwarz waveform format and transfers them to the Rohde & Schwarz generators.
- The Rohde & Schwarz Matlab transfer toolkit (AN 1GP60) loads I/Q signals generated using MATLAB® directly into a Rohde & Schwarz signal generator via GPIB or a TCP/IP connection.

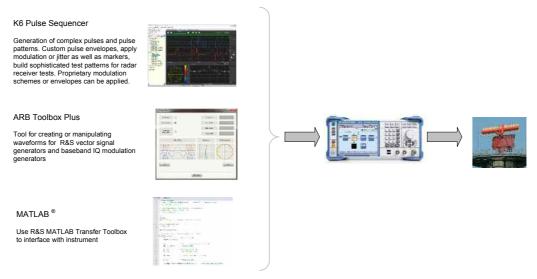


Figure 15: Loading data into the arbitrary waveform generator, three ways

2.3.2 Measurement on more complex pulsed Radar Systems

Zero Span Measurements

The R&S FSW can be used in conjunction with the R&S FSW-K7 AM/FM/PM measurement demodulator to perform a functional check on pulse compression radar systems. Thus radar transmitters which use linear or non-linear FM techniques can be checked, see Fig. 16.



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Figure 16: Characterizing a non-linear FM chirp radar transmitter

Fig. 17 shows a 13 bit Barker code demodulated with FSW-K7 in the upper part along with the appropriate pulse power of the RF signal in the lower part.

Some care has to be taken concerning the phase synchronization of the pulse demodulator. The *ZERO PHASE REF POS* softkey defines for this purpose the position at which the phase of the PM-demodulated signal is set to 0 rad. The entry is made with respect to time. In the default setting, the first measured value is set to 0 rad. The appropriate softkey is available only in the PM display with DC coupling. (*)

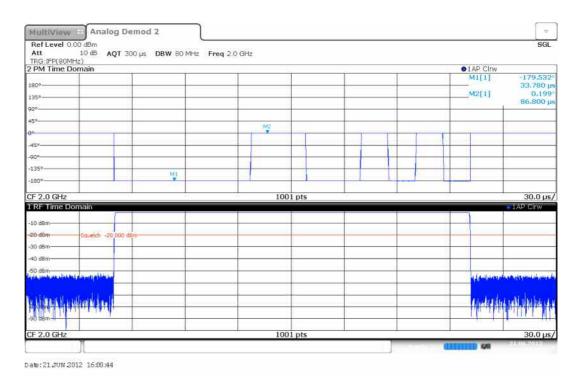


Figure 17: 13-bit Barker code demodulated along with FSW-K7

(*)FSW firmware versions issued before June 2012 need following pre-processed initialization via the remote control interface: "SENS:ADEM:PM:RPO:X 10us"

Automatic Detection of more complex Pulse Parameters

The R&S FSW-K6 pulse measurement application is a tool to measure and display various timing, amplitude, phase, and frequency related parameters. The application uses digital baseband data (I/Q data) captured by the R&S FSW. The available bandwidth is therefore given by the spectrum analyzers available I/Q bandwidth. I/Q data is time domain data and therefore allows time domain measurements, as well as evaluation of the signal's phase.

A pulsed input signal is a signal whose carrier power is modulated by two states: ON and OFF. Basically, a pulse is detected when the input signal power exceeds a threshold, then subsequently falls below that threshold, or vice versa. Details on pulse detection are given in ref. [34], chapter 4.2.

The signal flow chart in Fig. 18 provides an overview on how the FSW-K6 performs pulse measurements. The I/Q capture is followed by the pulse detection algorithm mentioned above, which defines the sections in the I/Q capture to be passed on to the measurement block. The measurement block finally calculates the pulse parameters. Default pulse measurements follow the IEEE 181 standard, but can be configured for user specific needs. Configurable settings are e.g. levels for rise-/fall-tim measurement, definition of settling time, and evaluation of pulse top level.



The following two measurement examples give an overview of the measurement functionalities provided by the R&S FSW-K6.

Figure 18: Signal flow chart of R&S FSW-K6 application

Example 1: measurement of linear FM chirped pulses

The first measurement example described here is the verification of a linear FM chirped pulse signal. In Fig. 19 the R&S FSW-K6 is configured to provide an overview window (Magnitude Capture) allowing the user to verify his capture settings. The result table is configured to show pulse width, chirp rate and frequency error. The numbers in the table allow a quick verification of design parameters as well as a comparison of one parameter over consecutive pulses. Fig. 19 also holds three intra-pulse displays, showing frequency, phase and magnitude. The intra-pulse displays each show one parameter over time for one selected pulse. Within the intra-pulse displays, unwanted effects, such as e.g. the rise and fall of the magnitude during the pulse on-time can be analyzed. The intra-pulse displays also allow manual marker measurements of e.g. the chirp rate.

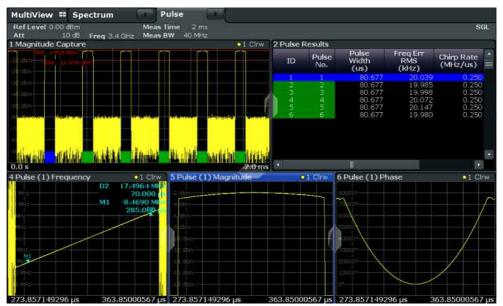


Figure 19: Pulse measurement on a linear FM chirped pulse signal

Example 2: measurement of varying PRI, pulse width and amplitude

This measurement example analyzes a signal with pulses varying in pulse repetition in PRI, width and amplitude. In this case, the R&S FSW-K6 was configured to display the result table along with a statistics table, the parameter trend for pulse width, and the overview window. The statistics table shows the same parameters as the result table, but calculates statistics, i.e. minimum, maximum, average, and standard deviation. The statistic display is split into two parts. The first part contains the statistics calculated over all pulses of the current capture buffer. This section is indicated with a green background, referencing the indicators in the magnitude capture graph. The second part displays the statistic numbers for all pulses, which were analyzed since the data acquisition was started. This statistical numbers are called cumulative statistic. The numbers in the two sections differ only, if the instrument is in continuous mode. In single sweep mode, both sections show identical numbers. To allow the user a comparison of pulse parameters over a large number of pulses, the result table can hold up to 100,000 datasets. So no matter how many pulses are in the current capture buffer, the table will fill up with the numerical results, if the instrument is in continuous mode. The results of the table can either be analyzed on the instrument, or exported into a file. The cumulative statistic as well as the table, capable of holding up to 100,000 dataset, is especially valuable when it comes to a measurement of very rare events. This is also important for trending information to see things like the heating effects running over long sequences and time.

The FSW-K6 also allows to display one parameter over all pulses in the I/Q memory. In Fig. 20 the parameter trend is shown for the pulse width. The trend display is ideally suited to identify repeating sequences, since signatures, such as the double peak in Fig. 20, can be easily identified.

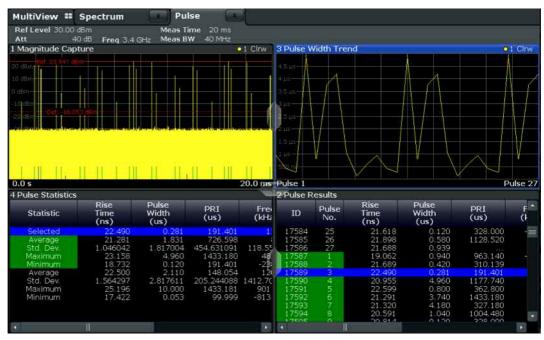


Figure 20: Pulse measurement of a pulsed signal with varying PRI

3 Automotive Applications

Today's automotive radar applications are focusing following items:

- speed surveillance
- crash avoidance
- parking assistance
- pedestrian detection

Automotive radar applications are dealing with much shorter distances of surveillance compare to Mil/Aero radar applications. While the latter are working in the range of 10ths of kilometres, the former are operated in the range from only a few centimeters up to roughly 200 meters.

The much smaller distance to be covered in automotive radar is causing two important technical differences in the appropriate systems:

- the equipment can be operated at much higher frequencies
- the radiated electric power can be smaller

Therefore, automotive radar works on operating bands such as 24..26 GHz or 76...77GHz and 77...81 GHz. In research and development, systems working at frequencies up to 110 GHz are in focus. Due to the smaller radiated power there is no mandatory need for pulsed transmission in automotive radar. To increase sensitivity, automotive radar systems are mainly working with a continuous frequency modulated signal, "FM-CW" in short.

As outlined in the White Paper 1MA207 test equipment for automotive radar systems are more focused on lower radiated power at higher frequencies compared to mil-aero radar test equipment.

While commercial last generation automotive radar systems still are working with mechanical beam steering, there is a clear trend towards digital beamforming (DBF), especially for 77 GHz systems where antenna arrays can be built on small footprints. Therefore all information related to DBF as provided earlier in this document, can be used for automotive radar systems in a similar way.

Signal generators SMB100A and SMF100A are ideal for automotive radar applications. Both instruments can be operated in their base configuration with frequencies up in the 40 GHz range. By means of external multipliers from the SMZ family the frequency range of SMF100A can be extended up to 110 GHz, thus covering the entire frequency range of modern automotive radar systems. SMB as well as SMF can provide FM modulated signals and therefore can be basically applied for automotive systems.

On the receiver side Signal and Spectrum Analyzers from the FSW family are best fitting automotive radar requirements due to low phase noise for oscillator tests along with the capability of analyzing short pulse rise and fall times.

Automotive radar systems as used along with cars are price-sensitive items of mass production. The car industry therefore normally tries to avoid expensive test

procedures in their productions lines. On-chip integrated self-test functions are an important measure for test cost reduction along with highly integrated MMIC devices.

Costs can additionally be reduced by using off-the-shelf preconfigured test equipment in cases where integrated self-test functions are not suitable. A vector network analyzer (VNA) is the best solution for this purpose, as shown in Fig. 21. Along with wafer probes and x-y-wafer positioning systems entire wafers can be tested before divided into their elements.

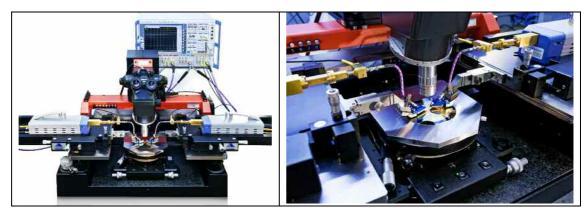


Figure 21: ZVA110 along with wafer probes and xy-positioning system

4 Special Radar Measurements

4.1 Measurement of Phase Noise in Local Oscillators

Making precision Doppler speed measurements requires testing of the phase noise of the coherent oscillators (COHO) and stable local oscillators (STALO) involved. In Doppler radar systems, excessive phase noise in the RF source and all of the other oscillators that are used in the radar system can mask targets at low speeds. In FMCW radar systems, targets in close proximity to the radar system can be masked.

The test instrument that is used for this measurement must meet very demanding requirements for the phase noise. The spectrum analyzers in the R&S FSU/R&S FSQ family from Rohde & Schwarz are well suited for such tests.

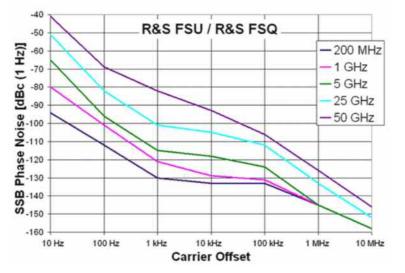


Figure 22: Typical intrinsic phase noise produced by the spectrum analyzers

The R&S FSUP signal source analyzer provides an extremely wide measurement dynamic range along with very flexible test capabilities. When equipped with the R&S FSUP-B60 option, the R&S FSUP signal source analyzer has two parallel receiving paths. Due to the symmetrical structure that exists, cross-correlation between the two paths is possible, allowing elimination of the uncorrelated intrinsic noise of the two reference sources. This method can be used within the instruments full frequency range from 10 MHz up to 50 GHz. The sensitivity is thus increased significantly and is no longer limited by the phase noise of the internal references. An improvement of up to 20 dB is possible depending on the number of averaging steps.

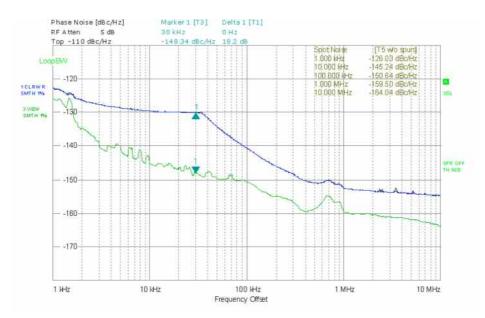


Figure 23: Intrinsic phase noise of the R&S FSUP in the L band

Fig. 23 shows phase noise measurement results with correlation using the R&S FSUP-B60 option (green curve) and uncorrelated (blue curve).

The R&S FSUP signal source analyzer offers the following comprehensive test capabilities for use in testing COHO/STALO:

- Phase-noise measurement using the phase-detector method with internal or external reference
- Direct phase-noise measurement with the spectrum analyzer
- Measurement of characteristic COHO/STALO oscillator parameters
- Tuning characteristic with constant and variable supply voltage
 - Tuning sensitivity
 - Output power vs. frequency and supply voltage
 - Spurious frequencies and harmonics
 - Transient response when changing frequencies

4.2 Automatic Noise Figure Measurements

R&S spectrum analyzers are ideal for making automatic measurements of the noise figure and gain due to their high sensitivity and power level accuracy in conjunction with the switchable calibrated noise sources. The R&S FS-K30 application firmware provides features for these high-performance analyzers which are otherwise available only in conjunction with special noise measuring setups. The following parameters can be measured with excellent precision at a defined frequency or across a selectable frequency range:

- Noise figure in dB
- Noise temperature in K
- Gain in dB

Besides LNAs, frequency converters can also be tested. The measurement results can be displayed in either graphical or tabular format.

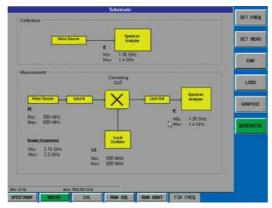


Figure 24: Frequency-converting DUT with R&S FS-K30

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	137.00 MHz	1.07 at		10.95 F	13.07 (0.61)		
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Figure 25: Measurements results of R&S FS-K30

4.3 Measurements on Phased Array Systems

As outlined in the White Paper 1MA207 electronic beamforming can be performed by means of antenna phase arrays which are feed by phase-shifted signals. In today's radar systems phase shifting is mainly achieved by electronic circuits, a typical example is described in Ref. [33]

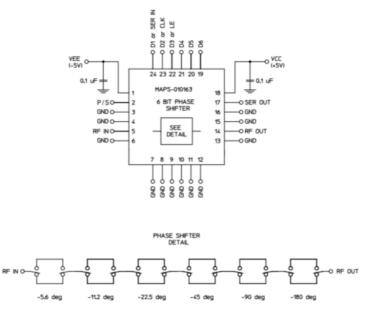


Figure 26: Digital Phase Shifter MMIC

Fig. 26 shows the appropriate block diagram. By means of a chain of six fixed-value phase shifters a total amount of 360 degrees can be achieved in steps of 5.6 degrees. The on-off-control signal of each shifting unit is digitally controlled, hence the term "Digital BeamFormer", "DBF" in short for this kind of device.

When combined with circulators, attenuators and switches we are talking about so called "transmit-receive-modules", "TRM" in short.

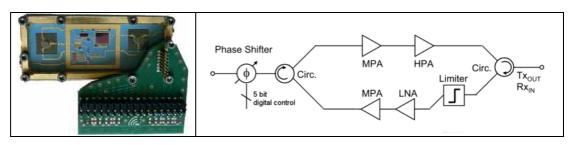


Figure 27: Sample TRM with block diagram

Fig. 27 shows an appropriate sample which has been created by R&S for test and demonstration purpose. In phased array radar systems such TRMs are used one for each antenna element, however implemented on a fairly higher integration scale in order to bring it into the top of a fighter plane for example.

Along with phase array radar systems multiple test scenarios have to be covered as listed below:

- Testing complete systems including transmitter, antenna and receiver (application area: R&D)
- Single modules, either on PCB or chip basis (application area : QA)
- Testing the integration into in the target system (application area : QA and Production)
- Diagnostics and calibration of entire systems (application area : Service and Maintenance)

Hence along with phased array radar systems for nearly each point of the value chain suitable test equipment is needed. R&S provides appropriate test solutions as listed below:

- Testing complete Phased Array systems: Vector network analyzers (ZVA, ZNB families) or generator / analyzer combinations (ex. SMB100A / FSW families)
- Stimulation and evaluation of digital radar control signals: Control Platform (OSP family) and digital oscilloscopes (RTO family)
- Testing complete radar systems including test software: TRM radar Test System (TS6710)
- Entry level solutions for typical small budget areas, ex. Service and Maintenance (Power Meter NRP-Z81)

When testing subsystems for instance as shown in Fig. 27 the vector network analyzer (VNA) is the ideal instrument. The RF ports of the DUT can be directly connected to the RF input and output port of the analyzer. Four independent output signals at the USER CONTROL connector along with simple extension circuitry can be used to control phase shifters and programmable attenuators as included in TRMs. Along with its internal command sequence capability the VNA can be easily configured as an automatic dedicated test device for TRM modules and appropriate radar systems.

For higher requirements R&S offers complete test systems for TRM modules, TS6710, as shown in Fig. 28.

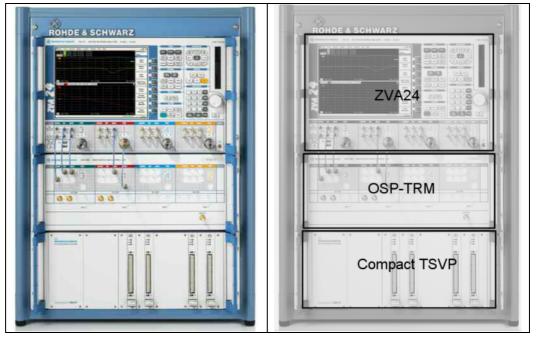


Figure 28: Test system for TRM evaluation

Along with its three main modules the test systems provides all tests needed for complete TRM module evaluation:

- ZVA24 for generating all incoming signals and evaluating all outputs in terms of the TRM's s-parameters.
- OSP-TRM for switching all RF signals to / from the TRM
- Compact TSVP for digital control of the TRMs, ex. Switching attenuators and phase shifters

The highly configurable software as included in the test system provides complete testsequences as well as single tests for in detail evaluation. Along with worldwide available field application engineers the test system is easily installed and brought to operation nearly everywhere over the world.

4.4 Component and Subassembly Tests

Achieving optimum performance in an overall radar system requires analysis and optimization of the individual functional groups and components. Looking to the block diagram of a typical radar system, refer to Fig. 29, various functional groups can be found as indicated by colors:

- 1. Filters, phase shifters, switches and waveguide joints, indicated in blue
- 2. Multiport devices like mixers and circulators, in green
- 3. Non-linear active and passive devices like amplifiers and limiters, in red
- 4. Antennas at the right
- 5. Mixed signal analog / digital components A/D converts and pulse generators, in yellow
- 6. Oscillators, so called "stable local oscillators" (STALOs), located close to the two upper mixers in the diagram

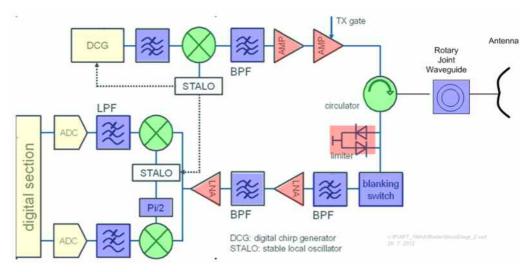


Figure 29: Typical block diagram for a single-antenna radar system

Functional groups 1 - 4 can be tested in all parameters using a Vector Network Analyzer (VNA). The best testing method for oscillators is by means of a phase noise analyzer, ex. FSUP. The subsequent text will provide more details how to test radar components using a VNA.

A VNA is highly suitable to test radar components

A VNA includes one or more independent RF transmitters and receivers. Each of the transmitters and receivers is covering a wide range in frequency and power. By means of individually controlling frequency and power of the VNA's transmitters and receivers the operating conditions of each block unit as shown in Fig. 29 can be simulated and tested within its normal operating conditions and beyond, if needed. Additionally the VNA is highly configurable in terms of additional components needed for tests, for instance filters, combiners, amplifiers, pulse-modulators and high power directional couplers. Finally the VNA is providing some important digital features as there are digital interfaces like USB-ports, a user control-port and programming capabilities which allow control programs to run directly on the machine without the need of an external control computer.

All this will contribute to an affordable and highly flexible test system for radar components as outlined in the upcoming text

VNA test scenarios specific to each of the functional groups 1-5

(1) Standard two port components like filters, switches (blue group)

Testing filters, switches/attenuators and waveguides belongs to the standard tasks of a VNA. Typical test parameters are reflection coefficients like S11 / S22 and transmission coefficients like S21 / S12. Predefined limit lines simplify testing and enable the user to evaluate the results in a reliable way, saving costs especially in the service and production area, refer to Fig. 30



Figure 30: radar X-band lowpass filter transfer characteristic with limit lines

(2) Multiport devices like Mixers and Circulators (green group)

The R&S®ZVA8/24/40/50 four-port models along with the ZVA-K4 frequency conversion option can directly measure mixer parameters like conversion gain, isolation, matching, group delay and intermodulation products without the need of an external generator. This configuration still needs access to the local oscillator input of the DUT.

The R&S®ZVA offers a new technique for measuring the group delay and relative phase of frequency converters without access to the embedded local oscillator or its reference signal. This method requires a four-port R&S®ZVA with two sources, ex. ZVA67, to apply a two-tone signal to the converter. The R&S®ZVA evaluates the group delay by measuring the phase differences between both carriers at the input and the output of the DUT.

radar receiver and transmitter systems require that the built-in mixers have wellcontrolled amplitude, phase, and group delay responses. The R&S®ZVA-K5 option makes it possible to characterize all four complex S-parameters of a mixer with LO access, including absolute phase and group delay of the conversion loss. This measurement uses full two-port calibration, which yields high measurement accuracy.

Circulators in radar systems are three port devices which route outgoing and incoming signals between the antenna, the transmitter and the receiver. Thus these non-reciprocal devices work as isolators, in which microwave power entering any port is transmitted to the next port in clockwise rotation. All additional power flow is omitted in the ideal case, refer to Fig. 31.

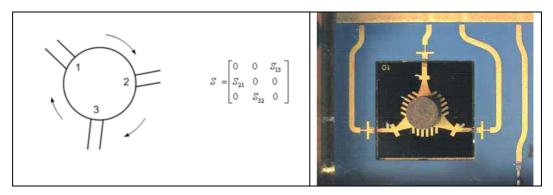


Figure 31: Circulator symbol, scattering matrix and real world unit

The appropriate s-matrix therefore consists of all zeros with the exception of S21, S32 and S13 as indicated in Fig. 31. This structure therefore can be easily measured using a VNA with at least three test ports. The matrix in Fig. 31 shows the ideal circulator structure only; however, by means of the VNA any deviation from this can be detected. This can be caused by reflections S11, S22 or S33 or unwanted backward transmissions, ex. S23.

(3) Non-linear active and passive devices like amplifiers and limiters

- Pulsed mode S-parameter measurements -

Components such as amplifiers are typically characterized in terms of their gain, frequency response, matching, and phase response by S-parameter measurements. S-parameter measurements are generally performed with a vector network analyzer using CW signals. However, this technique can be impractical with pulse radar components such as radar transmitter amplifiers which are designed for pulse mode operation. CW mode testing of an amplifier designed for pulse mode might result in thermal overloading and even may provide wrong test results.

Therefore the ZVA-K7 / B7 products have been created which allow S-parameter measurements in pulse mode. ZVA-K7 provides measurements on pulsed signals, pulse profile, recording time up to 3ms up to 30 MHz bandwidth for all ZVA and ZVT. Along with option ZVA-B7, which includes option ZVA-K7, recording times up to 25 ms are possible with the same bandwidth. Both options provide direct A/D-converter access with direct RAM storage resulting in fast post processing and s-parameter calculation. Further information on pulsed mode measurements is available as follows:

- Detailed description of the products ZVA-K7 and ZVA-B7 in the appropriate product brochure Ref. [7], pg. 17
- Article about the functionality of both options in Ref. [4]
- Complete example of pulsed S-parameter measurements on a radar L-Band power amplifier in Application Note 1MA126, Ref. [5]
- General information about pulsed mode amplifier tests in the book "Fundamentals of VNA", pg. 208, Ref. [2]

- Hardware extensions using ZVAX24 -

Sometimes additional electronic components are needed beyond the network analyzers and its options available. For this purpose the ZVAX24 extension unit has been created.

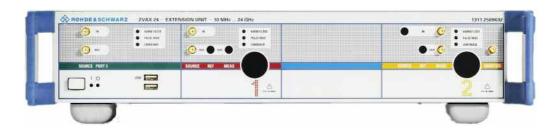




Figure 32: ZVAX24 front and rear view

Located beneath the ZVA network analyzer it is easily connected via some few cables. The extension unit is completely remotely controllable, and an appropriate Graphical User Interface is available within ZVA firmware.

Following options are available to be built into the extension unit:

Hardware extensions available for ZVAX24					
Function	Purpose	Option type			
Combiner	Generation of 2-Tone signals for intermodulation measurements	ZVAX-B211			
Harmonic filters	For extended dynamic range and spurious testing	ZVAX-B25x x = 1, 2, 3			
Pulse modulators	To generate pulsed signals for pulsed mode measurements, simple pulse trains can be generated from ZVA-K27, more sophisticated ones can be fed in from external equipment	ZVAX-B27x x = 1, 2, 3			
Directional couplers	Power couplers up to 43 dBm as replacement for ZVA internal couplers for high power S-parameter measurements	ZVAX-B29x x = 1, 2			

Following additional information is available related to the hardware extension base unit ZVAX24 and its options:

- Detailed product description and order numbers of the products ZVAX-B2xx in the product brochure of ZVA, Ref. [7], pg. 18 and 25
- Article about the functionality of the extension unit, Ref. [6]

- Mechanical integration

Passive radar applications need outdoor measurements with car mounted equipment. This is along with field test or signal collection applications. For this purpose it is useful to put the instrument combination into a portable rack as shown in Fig. 33 before mounting into a vehicle.

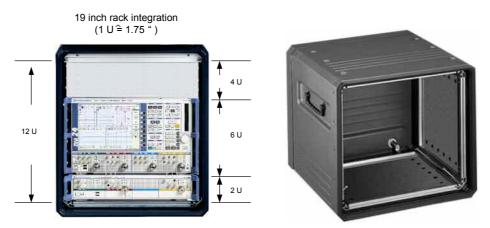


Figure 33: ZVA / ZVAX24 mounted in a 19" portable rack

The rack system as applied for the R&S UCS calibration system is available either via <u>http://www.knuerr.ch</u> ("INCAS"-System) or ask your local R&S dealer for a quotation on the R&S material-number 3522.1178.00 As shown in Fig. 33 there are still 4 Us remaining at the top which can be used for instance to build in an external signal generator or other special equipment.

By means of this configuration functional groups 1 to 4 of the radar system according to Fig. 29 can be tested either in indoor or outdoor / field applications.

Substitution of a Signal Generator for radar Components

During development of radar systems, signal generators can be very useful for detecting trouble spots in the system. A few applications are described in this section. For example, one can replace the stable local oscillator (STALO) with a signal generator featuring extremely low phase noise such as the R&S SMB100A (or even better, the R&S SMA100A) in order to check to what extent the STALO has a negative influence on the system performance due to its (presumably higher) phase noise, as shown in Fig. 34. The signal generator can also be used for testing the entire receiver part, i.e. when the exciter is not available.

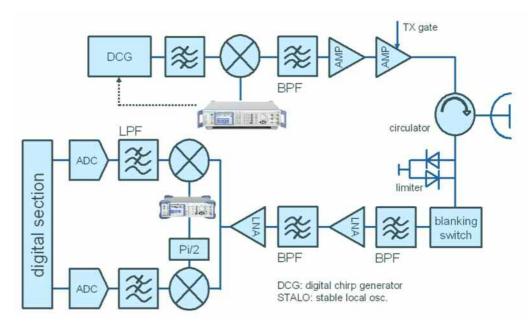


Figure 34: Using the R&S SMA100A or R&S SMB100A as a substitute for STALO

The entire transmitter unit in a radar system (except for the power amplifier) can be replaced with the R&S SMU200A vector signal generator capable of complex modulation signal generation capability to determine whether there are any problems in the signal processing, Fig. 35.

With pulse radar systems (without pulse compression) or when using linear FM chirp modulation with frequency deviations up to a maximum of 40 MHz, the R&S SMF microwave generator is suitable for use up to the highest RF frequencies (–43.5 GHz). The frequency multipliers R&S SMZ75/90/110 increase the frequency range up to 75/90/110 GHz respectively.

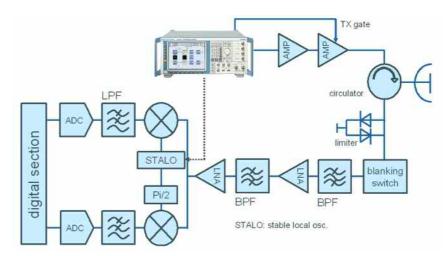


Figure 35: R&S SMU200A as a substitute for an exciter

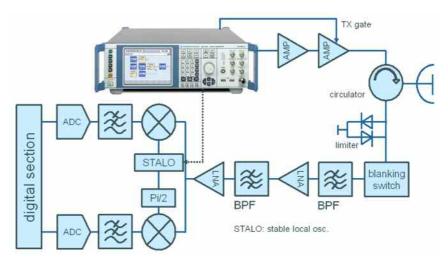


Figure 36: R&S SMF100A up to 43.5 GHz as a substitute for an exciter

The receiver unit in a radar system can be tested separately based on complex receiving scenarios. Useful instruments here include the R&S AFQ100A I/Q modulation generator in conjunction with the R&S SMU200A or R&S SMJ100A vector signal generator, allowing generation of very broadband signals (up to 200 MHz RF bandwidth) as well as very long signal sequences (up to 1 Gsample of memory) (Fig. 37).

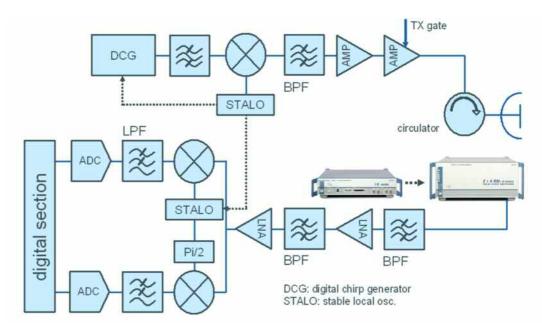


Figure 37: Receiver testing using complex waveforms

The R&S AFQ100A makes it possible to test the baseband receiver unit separately from the rest of the radar system by using broadband and very long sequences (real-world signals).

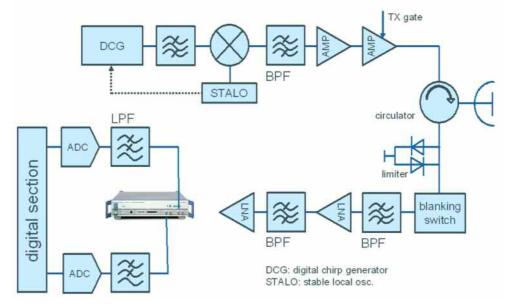


Figure 38: Testing long real-world scenarios using the R&S AFQ100A

5 Overview - R&S Radar related Products

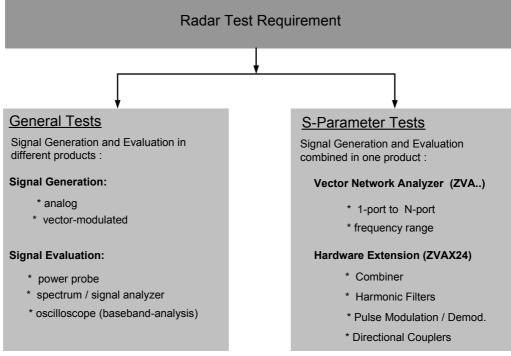


Figure 39: R&S radar product portfolio classification

The R&S product portfolio can be generally subdivided into two main groups as indicated in Fig. 39. The "General Test" group on the left is generators and receivers or power probes. They are clearly targeted either for signal generation or for signal evaluation. In contrast, Network analyzer-Products, shown on the right, always include at least one generator and at least one receiver in a single box. This property of combined generators and receivers makes them applicable for further radar measurements beyond basic s-Parameter tests, for instance intermodulation or noise figure measurements. In the upcoming paragraphs the products for "General Tests" are discussed first, followed by network analyzer as applied for radar tests.

Additionally there is the RTO which can be used for UWB signal analysis, multichannel coherent testing applications, and multiband coherent analysis systems.

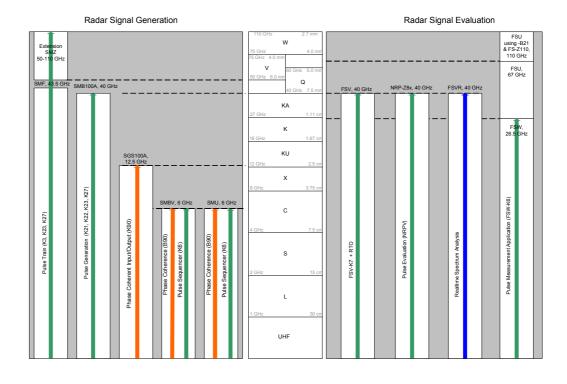


Figure 40: General test equipment for radar applications

Fig. 40 provides an overview of important radar related products offered by R&S. The figure consists of three different areas. The standard radar frequency bands are shown in the center along with the appropriate frequencies and wavelengths. The grey shaded area on the left includes important R&S products to generate radar signals. The grey shaded area on the right shows products to evaluate radar signals. Each product family is represented by a white vertical bar. The height of each bar is useful to get the appropriate radar bands to be covered by the specific product family. By means of the dashed lines, provided as reading aids, the radar bands covered by each product family can be seen. For instance the FSV family can be used to evaluate radar signals starting from the UHF band up to the KA-band ending at 40 GHz. For the sake of clarity the height of the product bars shows the total frequency range of the specific product family only.

The green and red colored vertical bars within the product families show the availability of following important radar related features

- pulse modulation capability either in generating or evaluating radar signals (green bars
- generating phase coherent signals (red bars)
- Real-time spectrum analysis with spectrum tracking over time (blue bar)

Pulse modulation is needed for all radar applications in order to optimize signal-tonoise ratio, detailed information is provided in the white paper 1MA207. Phase coherent signals are needed for steering antenna arrays as used in beamforming applications within AESA radar systems, chapter 4.9 of this document provides more details. The height of the green and red bars is indicating again the appropriate frequency range and thus the radar band to be covered. Hence, the radar X-band, important for defense applications, is covered by generator products SMF, SMB100A and the SGS100) along with their pulse modulation capabilities. On the evaluation side at the right of the diagram all three product families such as NRP-Z81, FSW and FSV can cover the radar X-band along with the appropriate pulse evaluation capability.

In order to define a radar test configuration following three steps are recommended in a first approach according to Fig. 40:

- 1. select the radar band to be covered using the vertical bar at the center of the diagram
- 2. pick one of the 4 products from the left for radar signal generation, by selecting the smallest possible frequency model
- 3. pick one of the 4 products from the right for radar signal evaluation, again selecting smallest frequency
- 4. the risetime of the signal of interest dictates the vector bandwidth required on the signal generation and analysis tools

Due to different technical concepts there are different investment costs in between the various solutions. For instance NRP-Z81 is a power probe with pulse evaluation capability. In contrast the two products FSW and FSV are spectrum analyzers are based on frequency converting technologies, where a down-converted intermediate frequency signal is post processed by fast DSPs after being A/D converted. Different technologies also make different prices. When taking NRP-Z81 as price reference of 1, we come to a price relationship of roughly 6:1 for FSW and roughly 5:1 for FSV compared to NRP-Z8x. radar applications based on NRP-Z8x therefore can be considered as lowest price entry point into radar test technology.

Beyond the so far mentioned radar flag-ship products, there are some additional products available for special radar applications which are not shown in Fig. 40. For instance when signal sources need to be tested in terms of phase noise the FSUP family is highly suitable; refer to the product pages at the end of this application note. For radar applications which always needs signal generation and evaluation at the same time, Network Analyzers and Test Systems are available as outlined in the subsequent text.

Vector Network Analyzers and Tests Systems for radar applications

Providing signal generation and evaluation at the same time is unique feature of radar test solutions introduced in this chapter. Due to their independent generators and receivers, Network Analyzers can be considered as small test systems, they provide

- signal generation according to radar requirements in terms of level and frequency range
- signal evaluation
- flexible in terms of hardware extension options
- powerful software control capability either internal or external

In addition to standard test instruments R&S offers complete radar test system solutions, providing the instrumentation hardware along with additional benefits as follows

- Test software, provided either as user-extendable source code or fully operational
- support in terms of on-site-installation, training and hotline; extendable by contract
- User tailored application specific hardware

For application specific hardware various platforms such as TSVP and OSP are available. Both are highly configurable and can be equipped either with standard options or by user-specific hardware. In the latter case the user don't has to take care four control interfaces, housing and power supply.

Currently there are two radar related test systems offered by R&S:

- RF frontend tester TS6600
- TRM module tester TS6710

Further details on both test systems are provided on the R&S homepage using the search tags "TS6600" and "TS6710" (*)

(*) tested on http://www2.rohde-schwarz.com at June 21th, 2012

6 R&S Instruments for Radar Applications

R&S SMF100A Microwave Generator: Special Features for radar Applications



- 1 GHz to 22 GHz or 43.5 GHz
- Extremely low phase noise and high rejection of harmonic and spurious signals
- Fast frequency and level setting times
- RF output up to +16 dBm (optionally up to +25 dBm)
- Flexible generation of single or double pulses and pulse trains
- Optional pulse modulator has on/off ratio greater than 80 dB, rise/fall times of <10 ns, and a minimum pulse width of 20 ns

http://www2.rohde-schwarz.com/product/SMF100A.html

R&S SMA100A Signal Generator: The Perfect Substitute for Local Oscillators



- 9 kHz to 3 GHz or 6 GHz
- Lowest SSB phase noise up to 6 GHz (typ. –140 dBc/Hz at 1 GHz with 20 kHz offset)
- Optional high-performance pulse generator and standard pulse modulator offer better than 80 dB on/off ratio, 20 ns rise/fall time and 20 ns pulse widths

http://www2.rohde-schwarz.com/product/SMA100A.html

R&S SMU200A Vector Signal Generator: Versatile Wideband Digital Modulation



- RF up to 6 GHz
- Optional second RF path up to 3 GHz
- Up to two internal baseband generators
- Versatile internal digital modulation
- I/Q modulator with 200 MHz RF bandwidth
- Pulse modulator
- Very low SSB phase noise
- Very high level repeatability of 0.05 dB
- High output power up to +19 dBm (PEP), overrange +26 dBm

http://www2.rohde-schwarz.com/product/SMU200A.html



R&S SMBV100A Vector Signal Generator: Signals for today and tomorrow

- RF up to 6 GHz
- Maximum output level up to 18 dBm and up to 24 dBm in the overrange
- Wide RF signal bandwidth of up to 120/500 MHz w. internal/external generators
- High flexibility in generating arbitrary signals
- Phase coherence option (B90)
- Pulse modulator / generator (K22/K23)
- Pulse sequencer software (K6)

http://www2.rohde-schwarz.com/product/SMBV100A.html

R&S RTO Family of Digital Oscilloscopes



- Bandwidth up to 4 GHz
- Optional logic analysis extension with mixed signal capability
- Digital trigger system operating in realtime
- High trigger sensitivity at full bandwidth
- Triggering and decoding of serial protocols
- Generic I/Q-Interface for external signal analysis (K11)
- Various types of probes:
 - active probe up to 3 GHz
 - active differential probe
 - current probe

http://www2.rohde-schwarz.com/product/RTO.html

R&S SMU-K6 Pulse Sequencer Software



- Standalone PC-based application
- Intuitive user interface with integrated waveform display and analysis
- Build pulse and sequence libraries
- Set any pulse parameter and add modulation such as AM, FM, PM, digital modulation, chirps
- Independently vary pulse parameters by applying jitter
- Plug-ins allow the user to add proprietary/classified pulse content
- Batch build multiple sequences and assemble multi-segment waveforms
- Transfer waveforms to instrument
- Also available for R&S SMBV, R&S SMJ, R&S AMU and R&S AFQ

http://www2.rohdeschwarz.com/en/products/test_and_measurement/signal_generation/SMUK6.html AFQ 100A Arbitrary Waveform Generators: Meeting New Challenges in radar Baseband Signal Generation



- Variable clock rate up to 300 MHz
- Maximum I/Q bandwidth of up to 100 MHz for an RF bandwidth of 200 MHz
- Ideal for generation of complex wideband radar signals with the R&S SMU
- Long signal duration 256 Msample or 1 Gsample
- Analog I/Q outputs (balanced and unbalanced)
- Optional digital outputs

http://www2.rohde-schwarz.com/product/AFQ100A.html

R&S NRP2 Power Meter: Handles up to Four Power Sensors



R&S NRP-Z51/55 Power Sensor: Thermoelectric Accuracy at Its Best

- DC to 40/50 or 67 GHz
- Measures average power with best possible accuracy
- Measurement range 1 µW to 100 mW
- Γ correction to reduce matching errors
- Operation of sensor directly from PC via USB interface

<u>http://www2.rohde-</u> <u>schwarz.com/en/products/broadcasting/broadcasting_measurement/NRPZ51.html</u> R&S NRP-Z81/85/86 Power Sensor: The Sensor of Choice for Analysis of radar Signals



- Frequency range from 50 MHz to 18 or 40 GHz
- Analysis of radar and communications signals up to 30 MHz RF bandwidth (sensor rise time <13 ns)
- Accurate continuous average power measurements on modulated and unmodulated signals from –60 dBm to +20 dBm
- Ultrafast statistical analysis (1 million point CCDF in 25 ms)
- Operation of sensor directly from PC via USB interface

<u>http://www2.rohde-</u> <u>schwarz.com/en/products/broadcasting/broadcasting_measurement/NRPZ81.html</u> R&S FSU Spectrum Analyzer Family: Models up to 67 GHz without External Mixers



- Models with upper frequency range of 3 GHz, 8 GHz, 26.5 GHz, 43 GHz, 46 GHz, 50 GHz, 67 GHz according to your needs
- R&S FSU67 is the only spectrum analyzer to cover the frequency range up to 67 GHz without external harmonic mixers and their inherent drawbacks
- Instrument-controlled internal RF attenuator (0 dB to 75 dB in 5 dB steps) eliminates the external, manually operated attenuator needed when harmonic mixers are used
- Reference level range (-130 dBm to +30 dBm) is much higher than typically achievable with harmonic mixers
- Unique choice for evaluating radar, electronic warfare, electronic countermeasures and battle-field communications systems
- Can make 80 measurements/s in manual mode and 70 measurements/s including data transfer over IEC/IEEE 488 bus
- Noise floor of -158 dBm at 1 GHz and -130 dBm at 65 GHz
- Resolution bandwidth of 1 Hz to 50 MHz
- Total measurement uncertainty <0.3 dB
- Frequency resolution of 0.01 Hz
- Low phase noise over entire measurement range
- Can function as an RF power meter just by adding a sensor
- Broad array of analysis options

http://www2.rohde-schwarz.com/product/FSU.html

R&S FSV40 Signal Analyzer: Vector Signal Analysis and Spectral Analysis in a Single Instrument



- Frequency range up to 3.6/7/13.6/30/40 GHz
- 40 MHz signal analysis bandwidth
- 0.4 dB level measurement uncertainty up to 7 GHz
- -110 dBc (1 Hz) phase noise at 10 kHz frequency offset
- Displayed average noise level (DANL) in 1 Hz bandwidth: –155 dBm at 1 GHz with R&S[®]FSV-B24 preamplifier: – 162dBm at 30 GHz
- +15 dBm third order intercept (TOI)
- Removable hard drive for applications where security is a concern
- Frequency range up to 110 GHz with external harmonics mixers

http://www2.rohde-schwarz.com/product/FSV.html

R&S FSW Signal and Spectrum Analyzer Setting standards in RF performance and usability



- Frequency range from 2 Hz to 8 GHz/13.6 GHz/26.5 GHz
- Low phase noise of -137 dBc (1 Hz) at 10 kHz offset (1 GHz carrier)
- Up to 160 MHz analysis bandwidth
- < 0.4 dB total measurement uncertainty up to 8 GHz
- High-resolution 12.1" (31 cm) touchscreen for convenient operation
- Multiple measurement applications can be run and displayed in parallel

http://www2.rohde-schwarz.com/product/FSW.html

R&S FSVR40 Real Spectral Analysis and Spectrum Analysis in a Single Instrument



- Frequency range from 10 Hz to 7 GHz, 13.6 GHz, 30 GHz or 40 GHz
- 40 MHz real-time analysis bandwidth for:
 - Spectrum with persistence function
 - Spectrogram display
 - Display of power versus time
- Triggering on frequency masks
- Measurement applications phase noise, noise figure, vector signal analysis, etc.
- Frequency range up to 110 GHz with external harmonics mixers

http://www2.rohde-schwarz.com/product/FSVR.html

R&S FSUP Signal Source Analyzer: Phase Noise Tester and High-End Spectrum Analyzer in a Single Instrument



- Frequency range up to 8/26.5/50 GHz
- Up to 110 GHz with external mixers
- Maximum flexibility in phase-noise measurements:
- Phase-detector method
- Phase-detector method with cross-correlation within full frequency rage
- Spectrum analyzer method
- Complete characterization of oscillators:
 - Phase noise
 - Transient response
 - Harmonics
- Maximum sensitivity in phase-noise measurements
- (e.g. at 1 GHz input frequency: -134 dBc (1 Hz) at 10 kHz offset)

http://www2.rohde-schwarz.com/product/FSUP.html

Vector Network Analyzers

The R&S ZVA series: Unparalleled measurement speed and accuracy



- 8, 24, 40, 50, 67, 80 or 110 GHz maximum measurement frequency
- Up to four test ports
- Industry-leading signal RF performance
- Wide dynamic range for fast and accurate measurements
 - >135 dB at test port
 - >145 dB with direct receiver access
- Segmented sweep increases speed, accuracy and dynamic range
- Pulse profile measurement with 12.5 ns time resolution and up to 30 MHz measurement bandwidth
- Point in pulse measurements for pulse widths down to 450 ns
- Parallel measurements up to four times faster
- Two internal phase coherent sources for true differential measurements
- Data transfer during sweeping
- High-speed control of external components
- Wide dynamic range and high sensitivity
 - >135 dB at test port, >145 dB with direct receiver access
 - <-115 dBm at test port, <-130 dBm with direct receiver access

The industry standard in pulse profile measurements

The **R&S ZVA-K7 Pulsed Measurements** option for the R&S ZVA and R&S ZVT series VNAs employs wideband detection and fast data recording for pulse profile measurements with high resolution at high speed.

http://www2.rohde-schwarz.com/product/ZVA.html

The R&S ZVT20: The first (and only) VNA with up to eight ports



- 300 kHz to 20 GHz
- Up to eight ports
- Dynamic range >120 dB
- Output power >13 dBm on all ports
- Power sweep range of -40 dBm to 13 dBm
- Measurement speed of 8 ms for all ports
- Simple configuration of multiport measurements
- Unlimited number of channels and traces
- Can simultaneously perform measurements on all ports of a device

http://www2.rohde-schwarz.com/product/ZVT20.html

7 Common Radar Abbreviations

Common radar Abbreviations		
Abbreviation	Meaning	
AESA	Active Electronically Scanned Array	
AEW	Airborne Early Warning	
AFC	Automatic-Frequency-Control	
AGC	Automatic Gain Control	
AM	Amplitude Modulation	
APAR	Active Phase Array radar	
ASR	Airport Surveillance radar	
ASR-S	Airport Surveillance radar Mode-S (Mode S is an extension to secondary radar. Mode S makes it possible to query additional information, e.g. the speed of the aircraft.)	
ATC	Air Traffic Control	
BARDS	Baseband radar Detection Sensor	
BSD	Blind Spot Detection	
BW	Bandwidth (or Beamwidth)	
CFAR	Constant False Alarm Rate	
CMOS	Complementary Metal-Oxide Semiconductor	
СОНО	Coherent Local Oscillator	
DBF	Digital Beam Forming	
DC	Direct Current (or Discrete Circuit)	
DOA	Direction of Arrival	
DoD	Department of Defense	
DSP	Digital Signal Processor	
DTM	Digital Terrain Model	
DUT	Device Under Test	
ECC	Error Correcting Code	
ECCM	Electronic Counter-Countermeasures	
EIRP	Effective Isotropic Radiated power	
ELINT	Electronic Intelligence (electronic acquisition of radar parameters)	
EMPAR	European Multifunction Phased Array radar	
EMV	Electromagnetic Vulnerability	
ESA	Electronically Steerable Array	
ESM	Electronic Warfare Support Measures	
ESP	Electronic Stability Program	
EW	Electronic Warfare	
FCC	Fault Collection Unit	

Common radar Abbreviations

Abbreviation	Meaning
FCC	Federal Communications Commission
FCW	Forward Collision Warning
FFT	Fast Fourier Transform
FMCW	Frequency Modulated Continuous Wave
FSK	Frequency Shift Keying
FTLO	Fast-Tracking Local Oscillator
GaAs	Gallium Arsenide
GaN	Gallium-Nitride
GCA	Ground-Controlled Approach
HF	High Frequency (3 - 30 MHz)
IF	Intermediate Frequency
LO	Local Oscillator
LO	Low Observability
LPI	Low Probability of Intercept
LRR	Long Range radar
LRU	Line-Replaceable Unit
MMIC	Microwave Monolithic Integrated Circuit
MTD	Moving Target Detection
MW	Megawatt
NAFTA	North American market
NRIET	Nanjing Research Institute of Electronic Technology
OTH	Over-The-Horizon
PA	Power Amplifier
PAR	Phased-Array-radar
PAR	Precision Approach radar
PDF	Pulse Desensitization Factor
PESA	Passive Electronically Scanned Array
PN	Pseudo-Noise
PRF	Pulse Repetition Rate or Frequency
PRI	Pulse Repetition Interval
PRT	Pulse Repetition Time
PSS	Predictive Safety System
RADAR	Radio Detection and Ranging
RAM	Random Access Memory, radar Absorbing Material, Rolling Airframe Missile, or Reliability, Availability and Maintainability
RBW	Resolution Bandwidth
RCS	radar Cross-Section
RDF	Range and Direction Finding
RS	Ramp Slope
RWR	radar Warning Receiver

Common radar Abbreviations

Abbreviation	Meaning
RX	Receive
SAM	Surface-to-Air Missile
SAR	Synthetic Aperture radar
SNR	Signal-to-Noise Ratio
SPI	Serial Peripheral Interface
SRR	Short Range radar
SSPA	Solid-State Power-Amplifier
SSR	Secondary Surveillance radar
STALO	Stable Local Oscillator
STAP	Space-Time Adaptive Processing
SWT	Software-Timer
T/R	Transmit/Receive
TBD	Track-Before-Detect
TRM	Transmitter-Receiver Module
TWT	Traveling Wave Tube
ТХ	Transmit
UHF	Ultra High Frequency
ULA	Uniform Linear Array
UWB	Ultra Wideband
VCO	Voltage Controlled Oscillator
VHF	Very High Frequency
VSA	Vector Signal Analyzer

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- Energy-efficient products
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Regional contact

Europe, Africa, Middle East +49 89 4129 12345 customersupport@rohde-schwarz.com

North America 1-888-TEST-RSA (1-888-837-8772) customer.support@rsa.rohde-schwarz.com

Latin America +1-410-910-7988 customersupport.la@rohde-schwarz.com

Asia/Pacific +65 65 13 04 88 customersupport.asia@rohde-schwarz.com

China

+86-800-810-8228 /+86-400-650-5896 customersupport.china@rohde-schwarz.com

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Rohde & Schwarz GmbH & Co. KG Mühldorfstraße 15 | D - 81671 München Phone + 49 89 4129 - 0 | Fax + 49 89 4129 – 13777

www.rohde-schwarz.com